

# Introduction to Beam Instrumentation

#### Linear Collider school 2013, Antalya

Hermann Schmickler – CERN Beam Instrumentation Group



#### Introduction

- What do we mean by beam instrumentation?
  - The "eyes" of the machine operators
    - i.e. the instruments that observe beam behaviour
    - An accelerator can never be better than the instruments measuring its performance!
- What does work in beam instrumentation entail?
  - Design, construction & operation of instruments to observe particle beams
  - R&D to find new or improve existing techniques to fulfill new requirements
  - A combination of the following disciplines
    - Applied & Accelerator Physics; Mechanical, Electronic & Software Engineering
  - A fascinating field of work!

#### What beam parameters do we measure?

- Beam Position
  - Horizontal and vertical throughout the accelerator
- Beam Intensity (& lifetime measurement for a storage ring/collider)
  - Bunch-by-bunch charge and total circulating current
- Beam Loss
  - Especially important for superconducting machines
- Beam profiles
  - Transverse and longitudinal distribution
- Collision rate / Luminosity (for colliders)
  - Measure of how well the beams are overlapped at the collision point



#### More Measurements

#### • Machine Tune



Characteristic Frequency of the Magnet Lattice Given by the strength of the Quadrupole magnets

#### Machine Chromaticity





### The Typical Instruments

- Beam Position
  - electrostatic or electromagnetic pick-ups and related electronics
- Beam Intensity
  - beam current transformers
- Beam Profile
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
  - ionisation and luminescence monitors
  - femtosecond diagnostics for ultra short bunches
  - Beam Loss
    - ionisation chambers or pin diodes
- Machine Tune and Chromaticity
  - In second part
- Luminosity Monitoring
  - in second part



## 

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#### Wall Current Monitor – Beam Response



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## Electrostatic Monitor – Beam Response



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#### **Electrostatic Pick-up – Button**

✓ Low cost  $\Rightarrow$  most popular

× Non-linear

 requires correction algorithm when beam is off-centre

For Button with Capacitance  $\rm C_{e}$  & Characteristic Impedance  $\rm R_{0}$ 

Transfer Impedance:

$$Z_{T(f>>f_c)} = \frac{A}{(2\pi r) \times c \times C_e}$$
  
Lower Corner Frequency:

$$f_L = \frac{1}{2\pi R_0 C_e}$$





 $X = 2.30 \cdot 10^{-5} X_1^{5} + 3.70 \cdot 10^{-5} X_1^{3} + 1.035 X_1 + 7.53 \cdot 10^{-6} X_1^{3} Y_1^{2} + 1.53 \cdot 10^{-5} X_1 Y_1^{4}$ Hermann Schmickler – CERN Beam Instrumentation Group



#### A Real Example – The LHC Button





#### Improving the Precision for Next Generation Accelerators

- Standard BPMs give intensity signals which need to be subtracted to obtain a difference which is then proportional to position
  - Difficult to do electronically without some of the intensity information leaking through
    - When looking for small differences this leakage can dominate the measurement
    - Typically 40-80dB (100 to 10000 in V) rejection  $\Rightarrow$  tens micron resolution for typical apertures
- Solution cavity BPMs allowing sub micron resolution
  - Design the detector to collect only the difference signal
    - Dipole Mode TM<sub>11</sub> proportional to position & shifted in frequency with respect to monopole mode



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#### Today's State of the Art BPMs

- Obtain signal using waveguides that only couple to dipole mode
  - Further suppression of monopole mode



#### Prototype BPM for ILC Final Focus

Required resolution of 2nm (yes nano!) in a 6×12mm diameter beam pipe
Achieved World Record (so far!) resolution of 8.7nm at ATF2 (KEK, Japan)







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#### Criteria for Electronics Choice so called "Processor Electronics"

- Accuracy
  - mechanical and electromagnetic errors
  - electronic components
- Resolution
- Stability over time
- Sensitivity and Dynamic Range
  - Acquisition Time
    - measurement time
    - repetition time
- Linearity
  - aperture & intensity
- Radiation tolerance

# CÉRN

#### **Processing System Families**





#### **LINEARITY Comparison**





#### **Amplitude to Time Normalisation**







#### **Amplitude to Time Normalisation**





### **BPM Acquisition Electronics** Amplitude to Time Normaliser

#### Advantages

- Fast normalisation (< 25ns)
  - bunch to bunch measurement
- Signal dynamic independent of the number of bunches
  - Input dynamic range ~45 dB
  - No need for gain selection
- Reduced number of channels
  - normalisation at the front-end
- ~10 dB compression of the position dynamic due to the recombination of signals
- Independent of external timing
- Time encoding allows fibre optic transmission to be used

#### Limitations

- Currently reserved for beams with empty RF buckets between bunches e.g.
  - LHC 400MHz RF but 25ns spacing
  - 1 bunch every 10 buckets filled
- Tight time adjustment required
- No Intensity information
- Propagation delay stability and switching time uncertainty are the limiting performance factors

## What one can do with such a System

#### Used in the CERN-SPS for electron cloud & instability studies.





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    - ionisation chambers or pin diodes
- Machine Tunes and Chromacitities
  - in diagnostics section of tomorrow
- Luminosity
  - in diagnostics section of tomorrow



#### **Current Transformers**



Fields are very low

Capture magnetic field lines with cores of high relative permeability

(CoFe based amorphous alloy Vitrovac:  $\mu_r = 10^5$ )

Beam current

 $eN_{g}$  $eN_q\beta c$ I Beam W

#### Transformer Inductance

$$L = \frac{\mu_0 \ \mu_r}{2\pi} w N^2 \ln \frac{r_0}{r_i}$$



#### The Active AC transformer



### Fast Beam Current Transformer



500MHz Bandwidth

Low droop (< 0.2%/µs)

#### **Acquisition Electronics**





#### Data taken on LHC type beams at the CERN-SPS

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### What one can do with such a System



Bad RF Capture of a single LHC Batch in the SPS (72 bunches)

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### The DC current transformer

- AC current transformer can be extended to very low frequency but not to DC (no dl/dt !)
- DC current measurement is required in storage rings
- To do this:
  - Take advantage of non-linear magnetisation curve
  - Apply a modulation frequency to 2 identical cores







# DCCT Principle – Case 1: no beam



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## Secondary Emission (SEM) Grids

- When the beam passes through secondary electrons are ejected from the wires
- The liberated electrons are removed using a polarisation voltage
- The current flowing back onto the wires is measured
- One amplifier/ADC chain is used for each wire





### **Profiles from SEM grids**



- Charge density measured from each wire gives a projection of the beam profile in either horizontal or vertical plane
- Resolution is given by distance between wires
- Used only in low energy linacs and transfer lines as heating is too great for circulating beams



#### **Wire Scanners**

- A thin wire is moved across the beam
  - has to move fast to avoid excessive heating of the wire
- Detection
  - Secondary particle shower detected outside the vacuum chamber using a scintillator/photo-multiplier assembly
  - Secondary emission current detected as for SEM grids
- Correlating wire position with detected signal gives the beam profile





#### **Beam Profile Monitoring using Screens**

#### Optical Transition Radiation

- Radiation emitted when a charged particle beam goes through the interface of 2 media with different dielectric constants
- surface phenomenon allows the use of very thin screens (~10 $\mu$ m)



### Beam Profile Monitoring using Screens

- Screen Types
  - Luminescence Screens
    - destructive (thick) but work during setting-up with low intensities
  - Optical Transition Radiation (OTR) screens
    - much less destructive (thin) but require higher intensity

Sensitivities measured with protons with previous screen holder,



Туре	Material	Activator	Sensitivity	
Luminesc.	CsI	T1	6 10 <sup>5</sup>	
"	$Al_2O_3$	0.5%Cr	3 107	
"	Glass	Ce	3 109	
"	Quartz	none	6 10 <sup>9</sup>	1
OTR [bwd]	Al		2 1010	
"	Ti		2 1011	
**	С		2 1012	
				-
Luminesc. GSI	P43: Gd <sub>2</sub> O <sub>2</sub> S	Tb	2 107	

normalised for 7 px/ $\sigma$ 



#### **Beam Profile Monitoring using Screens**

#### Usual configuration

- Combine several screens in one housing e.g.
  - Al<sub>2</sub>O<sub>3</sub> luminescent screen for setting-up with low intensity
  - Thin (~10um) Ti OTR screen for high intensity measurements
  - Carbon OTR screen for very high intensity operation



#### Advantages compared to SEM grids

- allows analogue camera or CCD acquisition
- gives two dimensional information
- high resolution: ~ 400 x 300 = 120'000 pixels for a standard CCD
- more economical
  - Simpler mechanics & readout electronics
- Time resolution depends on choice of image capture device
  - From CCD in video mode at 50Hz to Streak camera in the GHz range



#### **Luminescence Profile** Monitor



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#### **Luminescence Profile Monitor**



#### **CERN-SPS** Measurements

- Profile Collected every 20ms
- Local Pressure at ~5×10<sup>-7</sup> Torr





#### **The Synchrotron Light Monitor**





#### **The Synchrotron Light Monitor**





 $\sigma_{\rm h} = 0.68 {\rm mm}$ 



 $\sigma_v = 0.56$ mm





 $\sigma_{\rm h} = 0.70 {\rm mm}$ 



 $\sigma_v = 1.05$ mm





### **Measuring Ultra Short Bunches**

- Next Generation FELs & Linear Colliders
  - Use ultra short bunches to increase brightness or improve luminosity
- How do we measure such short bunches?
  - Transverse deflecting cavity

p⁺ @ LHC	250ps	
H <sup>-</sup> @ SNS	100ps	
e <sup>-</sup> @ ILC	500fs	
e <sup>-</sup> @ CLIC	130fs	
e <sup>-</sup> @ XFEL	80fs	
e <sup>-</sup> @ LCLS	75fs	



#### Electro-Optic Sampling – Non Destructive





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#### **Beam Loss Detectors**

- Role of a BLM system:
  - 1. Protect the machine from damage
  - 2. Dump the beam to avoid magnet quenches (for SC magnets)
  - 3. Diagnostic tool to improve the performance of the accelerator
- Common types of monitor
  - Long ionisation chamber (charge detection)
    - Up to several km of gas filled hollow coaxial cables
    - Position sensitivity achieved by comparing direct & reflected pulse
      - e.g. SLAC 8m position resolution (30ns) over 3.5km cable length
    - Dynamic range of up to 10<sup>4</sup>





### **Beam Loss Detectors**

- Common types of monitor (cont)
  - Short ionisation chamber (charge detection)
    - Typically gas filled with many metallic electrodes and kV bias
    - Speed limited by ion collection time tens of microseconds
    - Dynamic range of up to 10<sup>8</sup>



LHC



#### **Beam Loss Detectors**

- Common types of monitor (cont)
  - PIN photodiode (count detection)
    - Detect MIP crossing photodiodes
    - Count rate proportional to beam loss
    - Speed limited by integration time
    - Dynamic range of up to 10<sup>9</sup>







#### **BLM Threshold Level Estimation**

